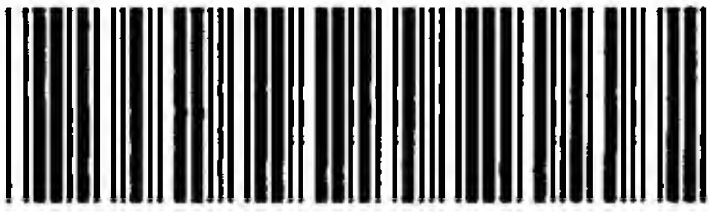


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/708,755	HSU ET AL.	
	Examiner	Art Unit	
	TAN X. DINH	2627	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (see search history printout)	6/15/2007	T.D
Consulted with primary examiner Bentsu Ro for searching class 318	6/18/2007	T.D